

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/709,487	LEE ET AL.	
Examiner		Art Unit	Rodney G. McDonald	
		1753	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0086639	05-2004	Grantham et al.	427/248.1
*	B	US-5,643,428	07-1997	Krivokapic et al.	204/298.11
*	C	US-5,330,628	07-1994	Demaray et al.	204/192.12
*	D	US-3,690,635	09-1972	Harker et al.	266/149
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	KR 2001-009208	02-2001	Korea	Jang et al.	
	O	07-150347	06-1995	Japan	hiramatsu et al.	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.